

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	19	(KU-JOSEPH KU-JOSEPH-W KU-JOSEPH-WEIYEH).in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/23 10:37
S2	2	"6230290".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/20 15:53
S3	2702	((built adj in adj self adj test) or ("BIST"))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 10:54
S4	2109	(((built adj in adj self adj test) or ("BIST")))) and memory	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/23 15:29
S5	1011	((built adj in adj self adj test) or ("BIST")) with memory	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/23 15:30
S6	438	(((built adj in adj self adj test) or ("BIST")) with memory) and tester	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/23 15:30
S7	155	(((built adj in adj self adj test) or ("BIST")) with memory) and tester) and algorithm	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/23 15:31
S8	122	((((built adj in adj self adj test) or ("BIST")) with memory) and tester) and algorithm) and @ad<="20010616"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/23 15:31
S9	8	second adj test adj algorithm	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 10:18

S10	6	failed adj memory adj information	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 10:20
S11	631	failed adj memory	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 10:20
S12	3	failed adj memory with data adj structure	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 10:25
S13	62960	data adj structure	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 10:26
S14	14	data adj structure same memory adj test	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 11:05
S15	3	data adj structure same BIST	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 11:12
S16	763	BIST and algorithm	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 11:13
S17	3	BIST and algorithm with download	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 11:13
S18	3219	redundant adj (cell or row or column) and memory	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 15:13
S19	10	(redundant adj (cell or row or column) and memory) and stop near2 test	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 13:13

S20	1	(multiple adj algorithm) and BIST	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 15:15
S21	8	((multiple or plurality or two) adj algorithm) and BIST	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 15:19
S22	5	((second) adj algorithm) and BIST	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/24 15:19
S23	259	714/723.ccls. and @ad<="20010616"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/25 13:15
S24	14783	"address field"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/25 13:05
S25	2789	"address field" and "bit field"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/25 13:05
S26	46	("address field" and "bit field") and BIST	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/25 13:06
S27	29	(("address field" and "bit field") and BIST) and @ad<="20010616"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/25 13:14
S28	47	failure near2 "data structure"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/25 13:13
S29	40	(failure near2 "data structure") and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/02/25 13:16

S30	531	714/30.ccls. and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 09:46
S31	252	714/57.ccls. and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 10:53
S32	3152	((built adj in adj self adj test) or ("BIST"))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 10:54
S33	99	((built adj in adj self adj test) or ("BIST")) and (computer with (communication adj link))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 10:55
S34	674	714/719.ccls. and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 10:21
S35	609	714/733.ccls. and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 10:57
S36	123	714/757.ccls. and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 10:57
S37	51	(714/723.ccls. and @ad<="20010626") and flag	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 10:58
S38	395	714/7.ccls. and @ad<="20010616"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 12:30
S39	396	714/7.ccls. and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 10:20

S40	673	714/719.ccls. and @ad<="20010616"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 10:20
S41	674	714/719.ccls. and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 12:32
S42	607	714/733.ccls. and @ad<="20010616"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 12:33
S43	609	714/733.ccls. and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 10:49
S44	123	714/757.ccls. and @ad<="20010616"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 12:34
S45	123	714/757.ccls. and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 12:34
S46	51	(714/723.ccls. and @ad<="20010616") and flag	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 12:35
S47	51	(714/723.ccls. and @ad<="20010626") and flag	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 10:52
S48	38	((built adj in adj self adj test) or ("BIST")) and (computer with (communication adj link))) and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/26 10:23
S49	445	chip adj tester	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 14:08

S50	160	(chip adj tester) and computer	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 14:08
S51	121	((chip adj tester) and computer) and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/25 14:09
S52	1289	((built adj in adj self adj test) or ("BIST")) and buffer	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/26 10:23
S53	214	((built adj in adj self adj test) or ("BIST")) and buffer) and (compar\$4 with buffer)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/26 10:24
S54	158	((built adj in adj self adj test) or ("BIST")) and buffer) and (compar\$4 with buffer)) and @ad<"20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/08/26 10:24
S55	13	714/7.ccls. and @ad<="20010616" and @pd>="20040826"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 09:43
S56	17	714/30.ccls. and @ad<="20010626" and @pd>="20040826"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 09:47
S57	13	714/7.ccls. and @ad<="20010626" and @pd>="20040826"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 10:20
S58	7	714/719.ccls. and @ad<="20010626" and @pd>="20040826"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 10:48
S59	13	714/733.ccls. and @ad<="20010626" and @pd>="20040826"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 10:50

S60	2	(714/723.ccls. and @ad<="20010626") and flag and @pd>="20040826"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 10:52
S61	8	714/57.ccls. and @ad<="20010626" and @pd>="20040826"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 10:53
S62	192	((IC or chip) adj tester) and (transmission or transmit or transmitted) and buffer	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 13:25
S63	139	((IC or chip) adj tester) and (transmission or transmit or transmitted) and buffer and @ad<="20010626"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/28 13:25